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Report No.: SZEM170800864704

Page: 1 of 8

1 Cover Page

RF MPE REPORT

Application No.:	SZEM1708008647CR	
Applicant:	icant: Hangzhou Hikvision Digital Technology Co., Ltd	
FCC ID:	2ADTD- K1A801EF	
Equipment Under Tes	t (EUT):	
NOTE: The following sa	ample(s) was/were submitted and identified by the client as	
Product Name:	Fingerprint Time Attendance Terminal	
Model No.(EUT):	DS-K1A801EF	
Add Model No.:	DS-K1A801F, DS-K1A801EF-1, DS-K1A801F-1, DS-K1A801F-B, DS-K1A801EF-B, DS-K1A802F, DS-K1A802EF, DS-K1A802EF-1, DS-K1A802F-1, DS-K1A802F-B, DS-K1A802F-E, DS-K1A802F-E, DS-K1A802YZ-UVW, DS-K1A802XYZ-UVW	
Standards:	FCC Rules 47 CFR §2.1091	
	KDB447498 D01 General RF Exposure Guidance v06	
Date of Receipt:	2017-03-29	
Date of Test:	2017-04-16 to 2017-08-10	
Date of Issue:	2017-08-22	
Test Result:	Pass*	

In the configuration tested, the EUT detailed in this report complied with the standards specified above.

EMC Laboratory Manager

The manufacturer should ensure that all products in series production are in conformity with the product sample detailed in this report. If the product in this report is used in any configuration other than that detailed in the report, the manufacturer must ensure the new system compiles with all relevant standards. Any mention of SGS International Electrical Approvals or testing done by SGS International Electrical Approvals in connection with, distribution or use of the product described in this report must be approved by SGS International Electrical Approvals in writing.

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Report No.: SZEM170800864704

Page: 2 of 8

Revision Record				
Version	Chapter	Date	Modifier	Remark
00	/	2017-08-22	/	Original

Authorized for issue by:		
Engineer	Vincent Zhu	2017-08-22
	Vincent Zhu /Project Engineer	Date
Reviewer	Parlam Zhan	2017-08-22
	Parlam Zhan /Reviewer	Date



Report No.: SZEM170800864704

Page: 3 of 8

2 Contents

		Pa	.ge
1	C	OVER PAGE	1
2	V	ERSIONERROR! BOOKMARK NOT DEFINI	ED.
3	C	CONTENTS	3
4	G	ENERAL INFORMATION	4
	4.1	CLIENT INFORMATION	4
	4.1	GENERAL DESCRIPTION OF E.U.T.	4
	4.2	TECHNICAL SPECIFICATIONS	4
	4.3	TEST LOCATION	5
	4.4	TEST FACILITY	5
5	T	EST STANDARDS AND LIMITS	6
	5.1	FCC RADIOFREQUENCY RADIATION EXPOSURE LIMITS:	6
6	\mathbf{M}	IEASUREMENT AND CALCULATION	7
	6.1	MAXIMUM TRANSMIT POWER	7
	6.2	MPE CALCULATION	8
7	E	UT CONSTRUCTIONAL DETAILS	8



Report No.: SZEM170800864704

Page: 4 of 8

3 General Information

3.1 Client Information

Applicant:	Hangzhou Hikvision Digital Technology Co., Ltd.	
Address of Applicant:	No. 555 Qianmo Road, Binjiang District, Hangzhou 310052, China	
Manufacturer:	Hangzhou Hikvision Digital Technology Co.	
Address of Manufacturer:	No. 555 Qianmo Road, Binjiang District, Hangzhou 310052, China	
Factory:	Hangzhou Hikvision Technology Co., Ltd. Hangzhou Hikvision Electronics Co., Ltd.	
Address of Factory:	1. No.700, Dongliu Road, Binjiang District, Hangzhou Ctiy,Zhejiang, 310052, China	
Address of Factory.	2. No.299, Qiushi Road, Tonglu Economic Development Zone, Tonglu County, Hangzhou, Zhejiang, 310052, China.	

3.1 General Description of E.U.T.

Product Description:	Fixed product with 125KHz RFID and 2.4GHz WiFi function
Rated Input:	DC 12V 1A
Test Voltage:	AC 120V 60Hz for adapter

3.2 Technical Specifications

Operation Frequency:	WIFI 802.11 b/g/n(HT20): 2412MHz-2462MHz 802.11 n(HT40): 2422MHz-2452MHz RFID 125KHz
Modulation Technique:	WIFI 802.11 b DSSS(CCK, DQPSK, DBPSK) 802.11 g/n(HT20)/n(HT40) OFDM(64QAM, 16QAM, QPSK, BPSK) RFID: ASK
Number of Channel:	WIFI 802.11 b/g/n(HT20): 11 802.11 n(HT40) 7 RFID:1
Antenna Type:	Integral Antenna
Antenna Gain:	2.4dBi for WiFi



Report No.: SZEM170800864704

Page: 5 of 8

3.3 Test Location

All tests were performed at:

SGS-CSTC Standards Technical Services Co., Ltd., Shenzhen Branch

No. 1 Workshop, M-10, Middle Section, Science & Technology Park, Shenzhen, Guangdong, China.

518057

Tel: +86 755 2601 2053 Fax: +86 755 2671 0594

3.4 Test Facility

The test facility is recognized, certified, or accredited by the following organizations:

• CNAS (No. CNAS L2929)

CNAS has accredited SGS-CSTC Standards Technical Services Co., Ltd. Shenzhen Branch EMC Lab to ISO/IEC 17025:2005 General Requirements for the Competence of Testing and Calibration Laboratories (CNAS-CL01 Accreditation Criteria for the Competence of Testing and Calibration Laboratories) for the competence in the field of testing.

A2LA (Certificate No. 3816.01)

SGS-CSTC Standards Technical Services Co., Ltd., Shenzhen EMC Laboratory is accredited by the American Association for Laboratory Accreditation(A2LA). Certificate No. 3816.01.

· VCCI

The 10m Semi-anechoic chamber and Shielded Room of SGS-CSTC Standards Technical Services Co., Ltd. have been registered in accordance with the Regulations for Voluntary Control Measures with Registration No.: G-823, R-4188, T-1153 and C-2383 respectively.

FCC –Designation Number: CN1178

SGS-CSTC Standards Technical Services Co., Ltd., Shenzhen EMC Laboratory has been recognized as an accredited testing laboratory.

Designation Number: CN1178. Test Firm Registration Number: 406779.

• Industry Canada (IC)

Two 3m Semi-anechoic chambers and the 10m Semi-anechoic chamber of SGS-CSTC Standards Technical Services Co., Ltd. Shenzhen Branch EMC Lab have been registered by Certification and Engineering Bureau of Industry Canada for radio equipment testing with Registration No.: 4620C-1, 4620C-2, 4620C-3.



Report No.: SZEM170800864704

Page: 6 of 8

4 Test Standards and Limits

4.1 FCC Radiofrequency radiation exposure limits:

According to §1.1310, the limit for general population/uncontrolled exposures

Frequency	Power density(mW/cm²)	Averaging time(minutes)
300MHz~1.5GHz	f/1500	30
1.5GHz~100GHz	1.0	30



Report No.: SZEM170800864704

Page: 7 of 8

5 Measurement and Calculation

5.1 Maximum transmit power

The Power Data is based on the RF Test Report SZEM170800864703.

Test Mode	Test Channel	Power[dBm]	Power[mW]
11B	2412	21.63	145.55
11B	2437	22.51	178.24
11B	2462	22.3	169.82
11G	2412	21.2	131.83
11G	2437	21.77	150.31
11G	2462	21.66	146.55
11N20SISO	2412	21.09	128.53
11N20SISO	2437	21.68	147.23
11N20SISO	2462	21.46	139.96
11N40SISO	2422	21.96	157.04
11N40SISO	2437	22.02	159.22
11N40SISO	2452	21.79	151.01



Report No.: SZEM170800864704

Page: 8 of 8

5.2 MPE Calculation

The Max Conducted Peak Output Power is 22.51dBm (178.24 mW);

The best case gain of the antenna is 2.4dBi. 2.4dB logarithmic terms convert to numeric result is nearly 1.74.

For FCC:

According to the formula S= $\frac{PG}{4R^2\pi}$, we can calculate S which is MPE.

Note:

dBm

- 1) P (Watts) = Power Input to antenna = 10^{10} / 1000
- 2) G (Antenna gain in numeric) = 10[^] (Antenna gain in dBi /10)
- 3) R = distance to the center of radiation of antenna (in meter) = 20cm
- 4) MPE limit = 1mW/cm²

$$S = \frac{PG}{4R^2\pi} = \frac{178.24 \times 1.74}{4 \times 400 \times 3.14} = 0.062 \text{ mW/cm}^2$$

So the device is exclusion from SAR test.

6 EUT Constructional Details

Refer to the < External Photos > & < Internal Photos >.

-- End of the Report--